

SONY**CXP740056/740096/740010**

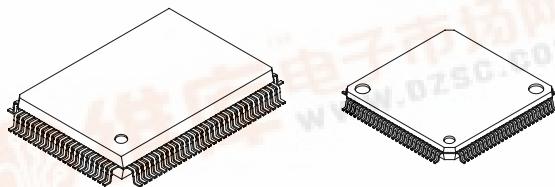
CMOS 8-bit Single Chip Microcomputer

Description

The CXP740056/740096/740010 is a CMOS 8-bit microcomputer integrating on a single chip an A/D converter, serial interface, timer/counter, time-base timer, capture timer/counter, remote control receive circuit, PWM output, and the like besides the basic configurations of 8-bit CPU, ROM, RAM, and I/O port.

The CXP740056/740096/740010 also provides the sleep/stop functions that enables lower power consumption.

100 pin QFP (Plastic) 100 pin LQFP (Plastic)



Structure

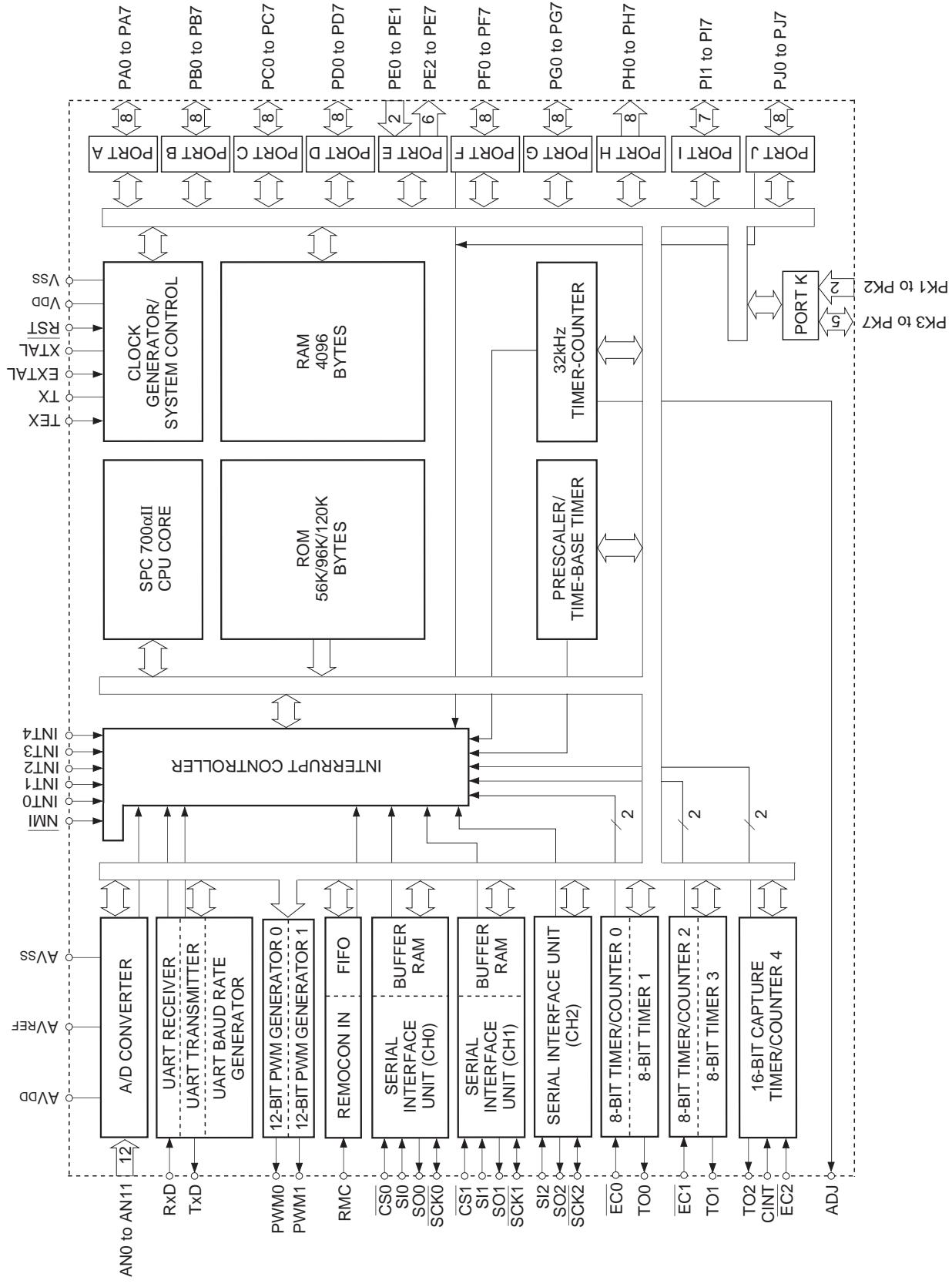
Silicon gate CMOS IC

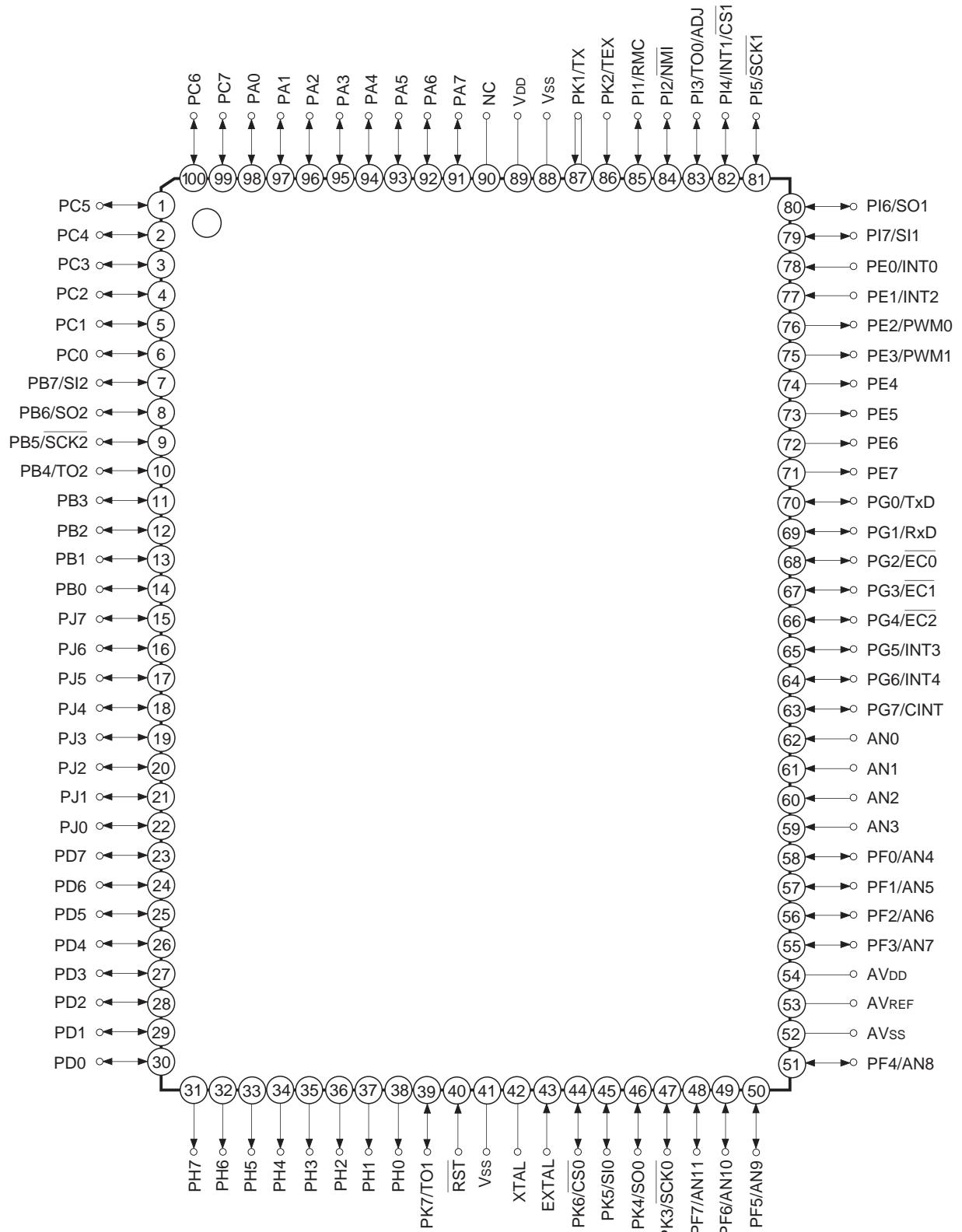
Features

- A wide instruction set (211 instructions) which covers various types of data.
 - 16-bit arithmetic/multiplication and division/Boolean bit operation instructions
- Minimum instruction cycle
 - 167ns at 24MHz operation (4.5 to 5.5V)
 - 333ns at 12MHz operation (2.7 to 5.5V)
 - 122 μ s at 32kHz operation (2.7 to 5.5V)
- Incorporated ROM capacity
 - 56K bytes (CXP740056)
 - 96K bytes (CXP740096)
 - 120K bytes (CXP740010)
- Incorporated RAM capacity
 - 4096 bytes
- Peripheral functions
 - A/D converter
 - 8 bits, 8 channels, successive approximation method
(Conversion time 10.3 μ s at 24MHz)
 - Serial interface
 - Start-stop synchronization (UART), 1 channel
 - Incorporated buffer RAM (Auto transfer for 1 to 32 bytes), 2 channels
 - 8-bit clock synchronization (MSB/LSB first selectable), 1 channel
 - Timer
 - 8-bit timer 2 channels, 8-bit timer/counter 2 channels,
 - 19-bit time-base timer, 16-bit capture timer/counter
 - 32kHz timer/counter
 - Remote control receive circuit
 - Noise elimination circuit
 - 8-bit pulse measuring counter, 6-stage FIFO
 - 12 bits, 2 channels
 - PWM output
- Interruption
 - 22 factors, 15 vectors, multi-interruption possible
- Standby mode
 - Sleep/stop
- Package
 - 100-pin plastic QFP/LQFP
- Piggy/evaluation chip
 - CXP740000

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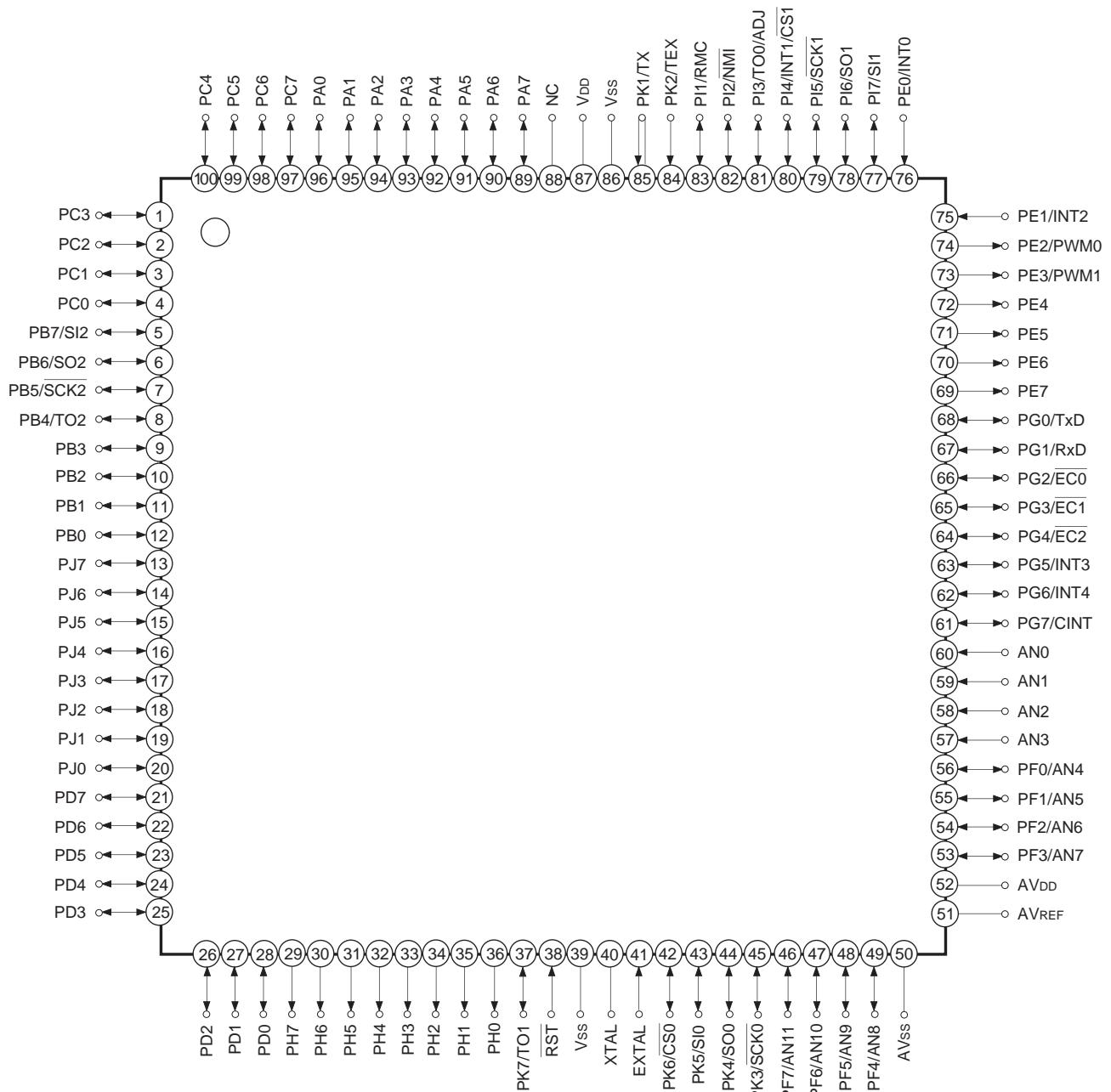
Block Diagram



Pin Assignment (Top View) 100-pin QFP package

Note) 1. NC (Pin 90) is left open.
2. Vss (Pins 41 and 88) are both connected to GND.

Pin Assignment (Top View) 100-pin LQFP package



Note) 1. NC (Pin 88) is left open.
2. Vss (Pins 39 and 86) are both connected to GND.

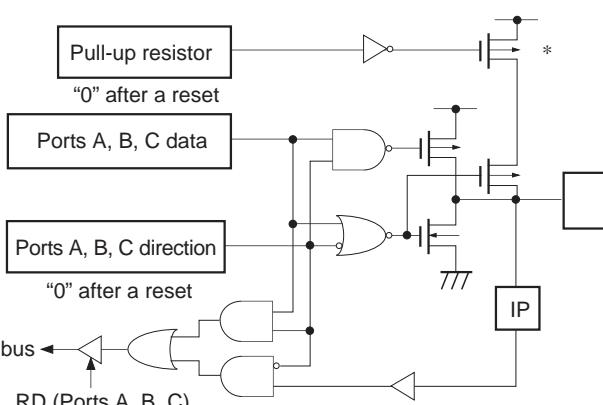
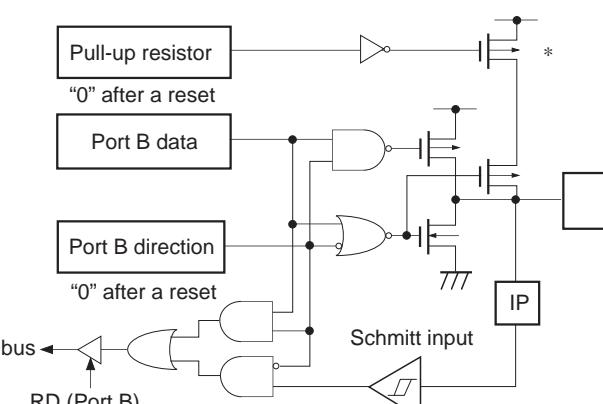
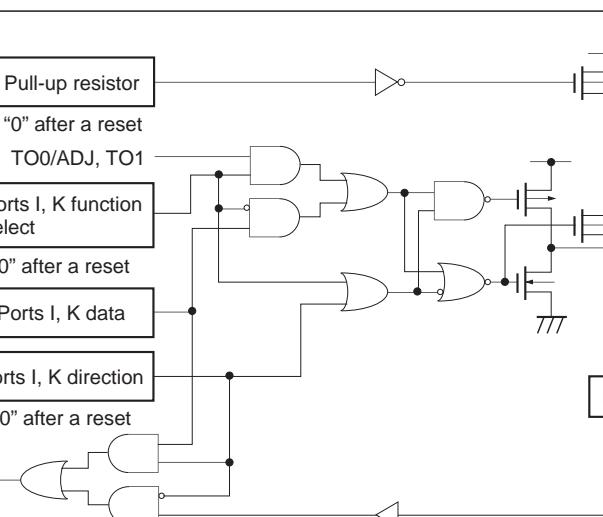
Pin Description

Symbol	I/O	Description	
PA0 to PA7	I/O	(Port A) 8-bit I/O port. I/O can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	
PB0 to PB3	I/O	(Port B) 8-bit I/O port. I/O can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	16-bit timer/counter rectangular wave output.
PB4/T02	I/O/Output		Serial clock I/O (CH2).
PB5/SCK2	I/O/I/O		Serial data output (CH2).
PB6/SO2	I/O/Output		Serial data input (CH2).
PB7/SI2	I/O/Input		
PC0 to PC7	I/O	(Port C) 8-bit I/O port. I/O can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	
PD0 to PD7	I/O	(Port D) 8-bit I/O port. I/O can be set in a unit of single bits. Can drive 12mA sink current. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	
PE0/INT0	Input/Input	(Port E) 8-bit port. Lower 2 bits are for input; upper 6 bits are for output. (8 pins)	External interrupt inputs. (2 pins)
PE1/INT1	Input/Input		12-bit PWM outputs. (2 pins)
PE2/PWM0	Output/Output		
PE3/PWM1	Output/Output		
PE4 to PE7	Output		
PF0/AN4 to PF7/AN11	I/O	(Port F) 8-bit I/O port. PF4 to PF7 can be set in a unit of single bits as standby release inputs. I/O can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	Analog inputs to A/D converter. (8 pins)

Symbol	I/O	Description	
PG0/TxD	I/O/Output	(Port G) 8-bit I/O port. I/O can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	UART transmission data output.
PG1/RxD	I/O/Input		UART reception data input.
PG2/ <u>EC0</u>	I/O/Input		External event input for 8-bit timer/counter 0.
PG3/ <u>EC1</u>	I/O/Input		External event input for 8-bit timer/counter 2.
PG4/ <u>EC2</u>	I/O/Input		External event input for 16-bit timer/counter.
PG5/INT3	I/O/Input		External interrupt inputs. (2 pins)
PG6/INT4	I/O/Input		
PG7/CINT	I/O/Input		External capture input to 16-bit timer/counter.
PH0 to PH7	Output	(Port H) 8-bit I/O port. Operated as N-ch open drain output for medium voltage drive (12V) and large current (12mA). (8 pins)	
PI1/RMC	I/O/Input	(Port I) 7-bit I/O port. I/O can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (7 pins)	Remote control receiver circuit input.
PI2/ <u>NMI</u>	I/O/Input		Non-maskable interrupt input.
PI3/TO0/ ADJ	I/O/Output/ Output		Output for the 8-bit timer/counter 1 rectangular waves and 32-kHz oscillation frequency demultiplication.
PI4/INT1/ CS1	I/O/Input/ Input		External interrupt input Chip select input for serial interface (CH1).
PI5/ <u>SCK1</u>	I/O/I/O		Serial clock I/O (CH1).
PI6/SO1	I/O/Output		Serial data output (CH1).
PI7/SI1	I/O/Input		Serial data input (CH1).
PJ0 to PJ7	I/O	(Port J) 8-bit I/O port. I/O can be set in a unit of single bits. Standby release input can be set in a unit of single bits. Incorporation of pull-up resistor can be set through the program in a unit of single bits. (8 pins)	
PK1/TX	Input	(Port K) 7-bit port. lower 2 bits are for input; upper 5 bits are for I/O. I/O can be set in a unit of single bits. For PK3 to PK7, incorporation of pull-up resistor can be set through the program in a unit of single bits. (7 pins)	Crystal connectors for 32-kHz timer/counter clock oscillation circuit. For usage as event count, connect clock oscillation source to TEX, and leave TX open.
PK2/TEX	Input/Input		Serial clock I/O (CH0).
PK3/ <u>SCK0</u>	I/O/I/O		Serial data output (CH0).
PK4/SO0	I/O/Output		Serial data input (CH0).
PK5/SI0	I/O/Input		Chip select input for serial interface (CH0).
PK6/ <u>CS0</u>	I/O/Input		
PK7/TO1	I/O/Output		8-bit timer/counter 3 rectangular wave output.

Symbol	I/O	Description
AN0 to AN3	Input	Analog inputs to A/D converter. (4 pins)
EXTAL	Input	Connects a crystal for system clock oscillation. When a clock is supplied externally, input it to EXTAL pin and input a reversed phase clock to XTAL pin.
XTAL		
RST	Input	System reset; active at Low level.
NC		Not connected. Leave this pin open for normal operation.
AV _{DD}		Positive power supply of A/D converter.
AV _{REF}	Input	Reference voltage input of A/D converter.
AV _{ss}		GND of A/D converter.
V _{DD}		Positive power supply.
V _{ss}		GND. Connect both V _{ss} pins to GND.

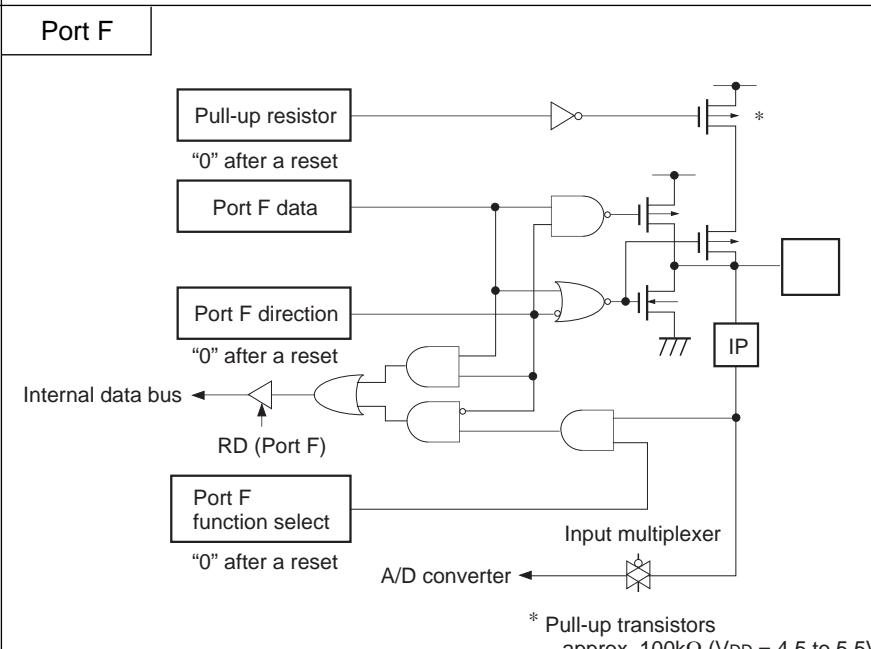
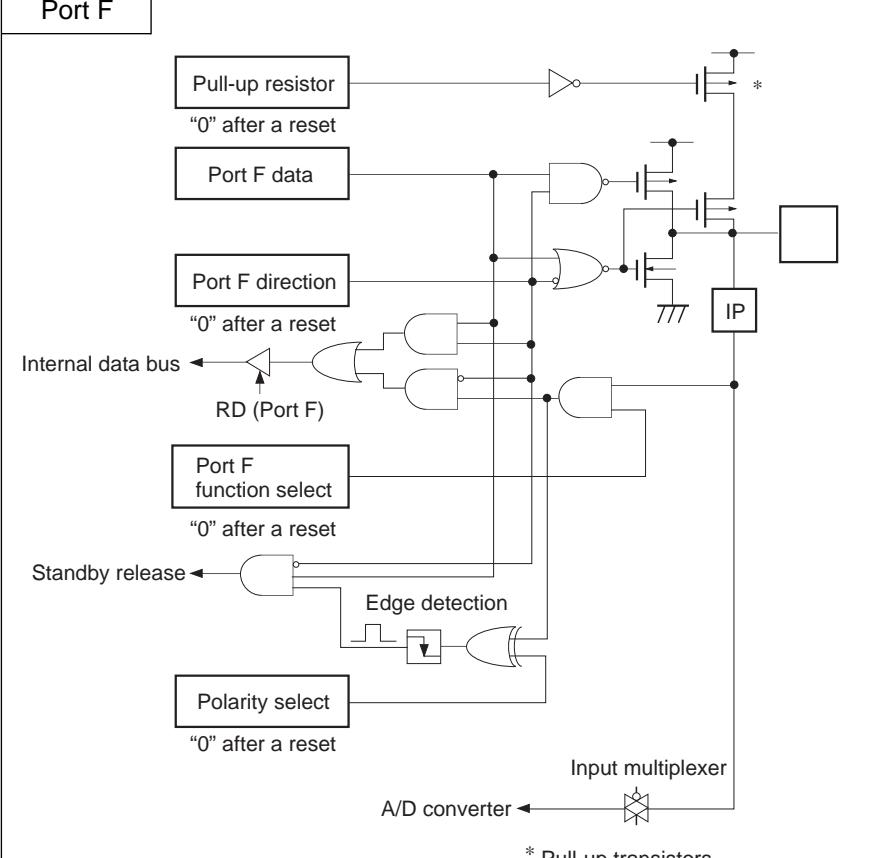
I/O Circuit Format for Pins

Pin	Circuit format	After a reset
PA0 to PA7 PB0 PB2 PC0 to PC7 18 pins	 <p>Port A Port B Port C</p> <p>Pull-up resistor "0" after a reset Ports A, B, C data</p> <p>Ports A, B, C direction "0" after a reset</p> <p>Internal data bus</p> <p>RD (Ports A, B, C)</p> <p>IP</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z
PB1 PB3 2 pins	 <p>Port B</p> <p>Pull-up resistor "0" after a reset Port B data</p> <p>Port B direction "0" after a reset</p> <p>Internal data bus</p> <p>RD (Port B)</p> <p>Schmitt input</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z
PB4/TO2 PI3/TO0/ADJ PK7/TO1 3 pins	 <p>Port I Port K</p> <p>Pull-up resistor "0" after a reset</p> <p>TO0/ADJ, TO1</p> <p>Ports I, K function select "0" after a reset</p> <p>Ports I, K data</p> <p>Ports I, K direction "0" after a reset</p> <p>Internal data bus</p> <p>RD (Ports B, I, K)</p> <p>IP</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z

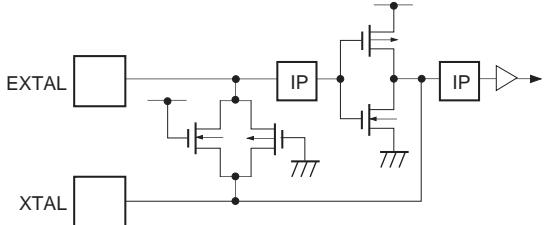
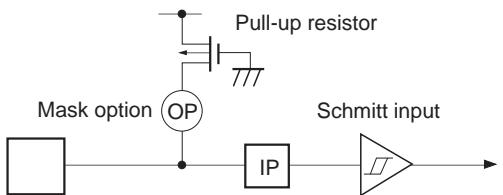
Pin	Circuit format	After a reset
PB5/SCK2 PI5/SCK1 PK3/SCK0 3 pins	<p>Port B Port I Port K</p> <p>The circuit diagram shows the internal logic for three pins. It includes Port B, I, K function select, data, and direction logic. RD (Ports B, I, K) is connected to the internal data bus. SCK2, SCK1, SCK0 are driven by buffers. A Schmitt input is also present.</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z
PB6/SO2 PG0/TxD PI6/SO1 PK4/SO0 4 pins	<p>Port B Port G Port I Port K</p> <p>The circuit diagram shows the internal logic for four pins. It includes Port B, G, I, K function select, data, and direction logic. RD (Ports B, G, I, K) is connected to the internal data bus. TO2, SO2, TxD, SO1, SO0 are driven by buffers. A Schmitt input is also present.</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z

Pin	Circuit format	After a reset
PB7/SI2 PG1/RxD PG2/EC0 PG3/EC1 PG4/EC2 PG5/INT3 PG6/INT4 PG7/CINT PI1/RMC PI2/NMI PI4/INT1/CS1 PI7/SI1 PK5/SI0 PK6/CS0	<p>Port B</p> <p>Port G</p> <p>Port I</p> <p>Port K</p> <p>"0" after a reset</p> <p>Ports B, G, I, K data</p> <p>Ports B, G, I, K direction</p> <p>"0" after a reset</p> <p>Internal data bus</p> <p>RD (Ports B, G, I, K)</p> <p>SI2, RxD, EC0, EC1, EC2, INT3, INT4, CINT, RMC, NMI, INT1/CS1, SI1, SI0, CS0</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z
14 pins		
PD0 to PD7	<p>Port D</p> <p>Pull-up resistor</p> <p>"0" after a reset</p> <p>Port D data</p> <p>Port D direction</p> <p>Internal data bus</p> <p>RD (Port D)</p> <p>*1 Large current 12mA (VDD = 4.5 to 5.5V) 4.5mA (VDD = 2.7 to 3.3V)</p> <p>*2 Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z
8 pins		
PE0/INT0 PE1/INT2	<p>Port E</p> <p>Schmitt input</p> <p>INT0, INT2</p> <p>Internal data bus</p> <p>RD (Port E)</p>	Hi-Z
2 pins		

Pin	Circuit format	After a reset
PE2/PWM0 PE3/PWM1 2 pins	<p>Port E</p> <p>PWM0, PWM1</p> <p>Port E function select "0" after a reset</p> <p>Port E data</p> <p>Internal data bus ← RD (Port E)</p> <p>Hi-Z by writing to Port E data register or Port E function select register → Output active</p>	Hi-Z
PE4 PE5 2 pins	<p>Port E</p> <p>Port E data</p> <p>Internal data bus ← RD (Port E)</p> <p>Hi-Z by writing to Port E data register → Output active</p>	Hi-Z
PE6 1 pin	<p>Port E</p> <p>Port E data "1" after a reset</p> <p>Internal data bus ← RD (Port E)</p>	High level
PE7 1 pin	<p>Port E</p> <p>Internal reset signal</p> <p>Port E data "1" after a reset</p> <p>Internal data bus ← RD (Port E)</p> <p>* Pull-up transistors approx. 150kΩ (VDD = 4.5 to 5.5V) approx. 200kΩ (VDD = 2.7 to 3.3V)</p>	"H" level "H" level at ON resistance of pull-up transistor during a reset.
AN0 to AN3 4 pins	<p>Input multiplexer</p> <p>IP</p> <p>A/D converter</p>	Hi-Z

Pin	Circuit format	After a reset
PF0/AN4 to PF3/AN7 4 pins	 <p>Port F</p> <p>Pull-up resistor "0" after a reset</p> <p>Port F data "0" after a reset</p> <p>Port F direction "0" after a reset</p> <p>Internal data bus</p> <p>RD (Port F)</p> <p>Port F function select "0" after a reset</p> <p>Input multiplexer</p> <p>A/D converter</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z
PF4/AN8 to PF7/AN11 4 pins	 <p>Port F</p> <p>Pull-up resistor "0" after a reset</p> <p>Port F data "0" after a reset</p> <p>Port F direction "0" after a reset</p> <p>Internal data bus</p> <p>RD (Port F)</p> <p>Port F function select "0" after a reset</p> <p>Standby release</p> <p>Edge detection</p> <p>Polarity select "0" after a reset</p> <p>Input multiplexer</p> <p>A/D converter</p> <p>* Pull-up transistors approx. 100kΩ (VDD = 4.5 to 5.5V) approx. 150kΩ (VDD = 2.7 to 3.3V)</p>	Hi-Z

Pin	Circuit format	After a reset
PH0 to PH7 8 pins	<p>Port H</p> <p>Port H data</p> <p>"1" after a reset</p> <p>Internal data bus</p> <p>RD (Port H)</p> <p>* High tension proof 12V Large current 12mA ($V_{DD} = 4.5$ to 5.5V) 4.5mA ($V_{DD} = 2.7$ to 3.3V)</p>	Hi-Z
PJ0 to PJ7 8 pins	<p>Port J</p> <p>Pull-up resistor</p> <p>"0" after a reset</p> <p>Port J data</p> <p>Port J direction</p> <p>"0" after a reset</p> <p>Internal data bus</p> <p>RD (Port J)</p> <p>Standby release</p> <p>Edge detection</p> <p>Polarity select</p> <p>"0" after a reset</p> <p>* Pull-up transistors approx. 100kΩ ($V_{DD} = 4.5$ to 5.5V) approx. 150kΩ ($V_{DD} = 2.7$ to 3.3V)</p>	Hi-Z
PK1/TX PK2/TEX 2 pins	<p>Port K</p> <p>TEX oscillation circuit control</p> <p>"1" after a reset</p> <p>Internal data bus</p> <p>RD (Port K)</p> <p>IP</p> <p>PK2/TEX</p> <p>PK1/TX</p> <p>Internal data bus</p> <p>RD (Port K)</p> <p>Schmitt input</p> <p>IP</p> <p>Clock input</p>	Oscillation stop port input

Pin	Circuit format	After a reset
EXTAL XTAL 2 pins	 <ul style="list-style-type: none"> Diagram shows circuit configuration during oscillation. When program stops the oscillation, the feedback register disconnects, and XTAL is driven at "H" level. 	Oscillation
RST 1 pin	 <p>Mask option</p> <p>Pull-up resistor</p> <p>Schmitt input</p>	"L" level (during a reset)

Absolute Maximum Ratings(V_{ss} = 0V reference)

Item	Symbol	Rating	Unit	Remarks
Supply voltage	V _{DD}	-0.3 to +7.0	V	
	AV _{DD}	AV _{ss} to +7.0* ¹	V	
	AV _{ss}	-0.3 to +0.3	V	
	AV _{REF}	AV _{ss} to +7.0	V	
Input voltage	V _{IN}	-0.3 to +7.0* ²	V	
Output voltage	V _{OUT}	-0.3 to +7.0* ²	V	
High level output current	I _{OH}	-5	mA	Output (value per pin)
High level total output current	ΣI _{OH}	-50	mA	Total for all output pins
Low level output current	I _{OL}	15	mA	All pins excluding large current outputs (value per pin)
	I _{OLC}	20	mA	Large current outputs (value per pin) * ³
Low level total output current	ΣI _{OL}	100	mA	Total for all output pins
Operating temperature	T _{opr}	-20 to +75	°C	
Storage temperature	T _{stg}	-55 to +150	°C	
Allowable power dissipation	P _D	600	mW	QFP package
		380		LQFP package

*¹ AV_{DD} and V_{DD} must be set to the same voltage.*² V_{IN} and V_{OUT} must not exceed V_{DD} + 0.3V.*³ The large current output pins are Port D and H (PD, PH).

Note) Usage exceeding absolute maximum ratings may permanently impair the LSI. Normal operation should be conducted under the recommended operating conditions. Exceeding these conditions may adversely affect the reliability of the LSI.

Recommended Operating Conditions

(Vss = 0V reference)

Item	Symbol	Min.	Max.	Unit	Remarks		
Supply voltage	VDD	4.5	5.5	V	fc = 24MHz or less	Guaranteed operation range for 1/2 and 1/4 frequency dividing clock.	
		2.7	5.5	V	fc = 12MHz or less		
		2.7	5.5	V	Guaranteed operation range for 1/16 frequency dividing clock or sleep mode		
		2.7	5.5	V	Guaranteed operation range for TEX		
		2.5	5.5	V	Guaranteed data hold operation range during stop mode		
Analog voltage	AVDD	2.7	5.5	V	*1		
High level input voltage	VIH	0.7VDD	VDD	V	*2, *6		
		0.8VDD	VDD	V	*2, *7		
	VIHS	0.8VDD	VDD	V	Hysteresis input*3		
	VIH _{EX}	VDD - 0.4	VDD + 0.3	V	EXTAL pin*4, *6, TEX pin*5, *6		
		VDD - 0.2	VDD + 0.2	V	EXTAL pin*4, *7, TEX pin*5, *7		
Low level input voltage	VIL	0	0.3VDD	V	*2, *6		
		0	0.2VDD	V	*2, *7		
	ViLS	0	0.2VDD	V	Hysteresis input*3		
	ViLEX	-0.3	0.4	V	EXTAL pin*4, *6, TEX pin*5, *6		
		-0.3	0.2	V	EXTAL pin*4, *7, TEX pin*5, *7		
Operating temperature	Topr	-20	+75	°C			

*1 AVDD and VDD must be set to the same voltage.

*2 Normal input port (PA, PB0, PB2, PB4, PB6, PC, PD, PF, PG0, PI3, PI6, PJ, PK1, PK2, PK4, PK7)

*3 RST, PB1, PB3, PB5/SCK2, PB7/SI2, PE0/INT0, PE1/INT2, PG1/RxD, PG2/EC0, PG3/EC1, PG4/EC2, PG5/INT3, PG6/INT4, PG7/CINT, PI1/RMC, PI2/NMI, PI4/INT1/CS1, PI5/SCK1, PI7/SI1, PK3/SCK0, PK5/SI0, PK6/CS0

*4 Specifies only when the external clock is input.

*5 Specifies only when the external event count is input.

*6 This case applies to the range of 4.5 to 5.5V supply voltage (VDD).

*7 This case applies to the range of 2.7 to 5.5V supply voltage (VDD).

Electrical Characteristics**DC Characteristics** ($V_{DD} = 4.5$ to 5.5 V)

(Ta = -20 to +75°C, Vss = 0V reference)

Item	Symbol	Pins	Conditions	Min.	Typ.	Max.	Unit
High level output voltage	V _{OH}	PA to PD, PE2 to PE7, PF to PG, PI to PJ, PK3 to PK7	$V_{DD} = 4.5$ V, $I_{OH} = -0.5$ mA	4.0			V
		PB5, PB6 ^{*1} , PG0 ^{*1} , PI5, PI6 ^{*1} , PK3, PK4 ^{*1}	$V_{DD} = 4.5$ V, $I_{OH} = -1.2$ mA	3.5			V
		PB5, PB6 ^{*1} , PG0 ^{*1} , PI5, PI6 ^{*1} , PK3, PK4 ^{*1}	$V_{DD} = 4.5$ V, $I_{OH} = -1.0$ mA	4.0			V
		PB5, PB6 ^{*1} , PG0 ^{*1} , PI5, PI6 ^{*1} , PK3, PK4 ^{*1}	$V_{DD} = 4.5$ V, $I_{OH} = -2.4$ mA	3.5			V
Low level output voltage	V _{OL}	PA to PD, PE2 to PE7, PF to PG, PI to PJ, PK3 to PK7	$V_{DD} = 4.5$ V, $I_{OL} = 1.8$ mA			0.4	V
		PA to PD, PE2 to PE7, PF to PG, PI to PJ, PK3 to PK7	$V_{DD} = 4.5$ V, $I_{OL} = 3.6$ mA			0.6	V
		PD, PH	$V_{DD} = 4.5$ V, $I_{OL} = 12.0$ mA			1.5	V
Input current	I _{IHE}	EXTAL	$V_{DD} = 5.5$ V, $V_{IH} = 5.5$ V	0.5		40	µA
	I _{ILE}		$V_{DD} = 5.5$ V, $V_{IL} = 0.4$ V	-0.5		-40	µA
	I _{IHT}	TEX	$V_{DD} = 5.5$ V, $V_{IL} = 5.5$ V	0.1		10	µA
	I _{ILT}		$V_{DD} = 5.5$ V, $V_{IL} = 0.4$ V	-0.1		-10	µA
	I _{ILR}	RST ^{*2}	$V_{DD} = 5.5$ V, $V_{IL} = 0.4$ V	-1.5		-400	µA
	I _{IL}	PA to PD ^{*3} , PF to PG ^{*3} , PI to PK ^{*3}				-45	µA
		RST ^{*2}	$V_{DD} = 4.5$ V, $V_{IL} = 4.0$ V	-2.78			µA
I/O leakage current	I _{Iz}	PA to PD ^{*3} , PF to PG ^{*3} , PI to PK ^{*3} , PE, AN0 to AN3 RST ^{*2}	$V_{DD} = 5.5$ V $V_I = 0, 5.5$ V			±10	µA
Open drain output leakage current (N-ch Tr off state)	L _{LOH}	PH	$V_{DD} = 5.5$ V $V_{OH} = 12$ V			50	µA

Item	Symbol	Pins	Conditions	Min.	Typ.	Max.	Unit
Supply current* ⁴	IDD1	V _{DD}	24MHz crystal oscillation (C ₁ = C ₂ = 15pF)		27	47	mA
			V _{DD} = 5V ± 0.5V				
	IDDS1		Sleep mode		1.0	5.0	mA
			V _{DD} = 5V ± 0.5V				
	IDD2		32kHz crystal oscillation (C ₁ = C ₂ = 47pF)		30	75	μA
			V _{DD} = 3V ± 0.3V				
	IDDS2		Sleep mode		12	40	μA
			V _{DD} = 3V ± 0.3V				
	IDDS3		Stop mode (Termination of EXTAL and TEX pins crystal oscillation)			10	μA
			V _{DD} = 5V ± 0.5V				
Input capacity	C _{IN}	PA to PD, PE0 to PE1, PF to PG, PI to PK, AN0 to AN3, <u>EXTAL</u> , <u>RST</u>	Clock 1MHz 0V for all pins excluding measured pins		10	20	pF

*¹ This case applies that Port B buffer capability switching register (BUFB: 010F4h, bits 6 and 5 = "1, 1") and Ports G/I/K buffer capability switching register (BUFG: 010F5h, bits 6, 5, 4, 3 and 0= "1, 1, 1, 1, 1") are ON.

*² RST pin specifies the input current when the pull-up resistor is selected, and specifies the leakage current when no resistor is selected.

*³ PA to PD, PF to PG and PI to PK pins specify the input current when the pull-up resistor is selected, and specify the leakage current when no resistor is selected.

*⁴ When all pins are open.

Electrical Characteristics**DC Characteristics** ($V_{DD} = 2.7$ to $3.3V$)

(Ta = -20 to +75°C, Vss = 0V reference)

Item	Symbol	Pins	Conditions	Min.	Typ.	Max.	Unit
High level output voltage	V _{OH}	PA to PD, PE2 to PE7, PF to PG, PI to PJ, PK3 to PK7	V _{DD} = 2.7V, I _{OH} = -0.12mA	2.5			V
		PB5, PB6* ¹ , PG0* ¹ , PI5, PI6* ¹ , PK3, PK4* ¹	V _{DD} = 2.7V, I _{OH} = -0.45mA	2.1			V
		PA to PD, PE2 to PE7, PF to PG, PI to PJ, PK3 to PK7	V _{DD} = 2.7V, I _{OH} = -0.24mA	2.5			V
		PD, PH	V _{DD} = 2.7V, I _{OH} = -0.9mA	2.1			V
Low level output voltage	V _{OL}	PA to PD, PE2 to PE7, PF to PG, PI to PJ, PK3 to PK7	V _{DD} = 2.7V, I _{OL} = 1.0mA			0.25	V
		PD, PH	V _{DD} = 2.7V, I _{OL} = 1.4mA			0.4	V
		PD, PH	V _{DD} = 2.7V, I _{OL} = 4.5mA			0.9	V
Input current	I _{IHE}	EXTAL	V _{DD} = 3.3V, V _{IH} = 3.3V	0.3		20	μA
	I _{IIE}		V _{DD} = 3.3V, V _{IL} = 0.3V	-0.3		-20	μA
	I _{IHT}	TEX	V _{DD} = 3.3V, V _{IL} = 3.3V	0.1		10	μA
	I _{IIT}		V _{DD} = 3.3V, V _{IL} = 0.4V	-0.1		-10	μA
	I _{IIR}	RST* ²	V _{DD} = 3.3V, V _{IL} = 0.3V	-0.9		-200	μA
	I _{IIL}	PA to PD* ³ , PF to PG* ³ , PI to PK* ³				-20	μA
		AN0 to AN3 RST* ²	V _{DD} = 3.3V, V _{IL} = 2.7V	-1.0			μA
I/O leakage current	I _{Iz}	PA to PD* ³ , PF to PG* ³ , PI to PK* ³ , PE, AN0 to AN3 RST* ²	V _{DD} = 3.3V V _I = 0, 3.3V			±10	μA
Open drain output leakage current (N-ch Tr off state)	L _{LOH}	PH	V _{DD} = 3.3V V _{OH} = 12V			50	μA

Item	Symbol	Pins	Conditions	Min.	Typ.	Max.	Unit
Supply current ^{*4}	IDD1	VDD	12MHz crystal oscillation (C ₁ = C ₂ = 15pF)		8	20	mA
	IDDS1		V _{DD} = 3.0V ± 0.3V ^{*3}				
	IDDS3		Sleep mode V _{DD} = 3.0V ± 0.3V		0.3	1.5	mA
			Stop mode (Termination of EXTAL and TEX pins crystal oscillation) V _{DD} = 3.0V ± 0.3V			10	µA
Input capacity	C _{IN}	PA to PD, PE0 to PE1, PF to PG, PI to PK, AN0 to AN3, <u>EXTAL</u> , RST	Clock 1MHz 0V for all pins excluding measured pins		10	20	pF

*1 This case applies that Port B buffer capability switching register (BUFB: 010F4h, bits 6 and 5 = "1, 1") and Ports G/I/K buffer capability switching register (BUFG: 010F5h, bits 6, 5, 4, 3 and 0 = "1, 1, 1, 1, 1") are ON.

*2 RST pin specifies the input current when the pull-up resistor is selected, and specifies the leakage current when no resistor is selected.

*3 PA to PD, PF to PG and PI to PK pins specify the input current when the pull-up resistor is selected, and specify the leakage current when no resistor is selected.

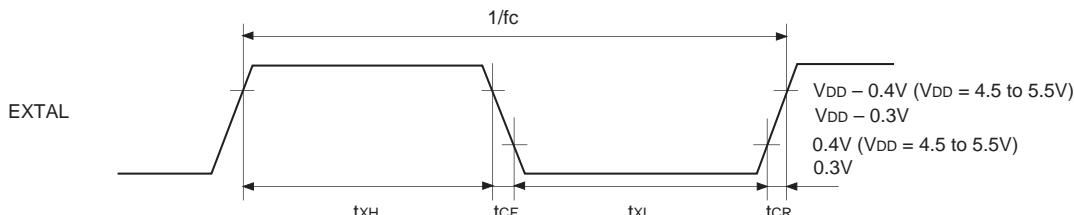
*4 When all pins are open.

AC Characteristics**(1) Clock timing**(Ta = -20 to +75°C, V_{DD} = 2.7 to 5.5V, V_{SS} = 0V reference)

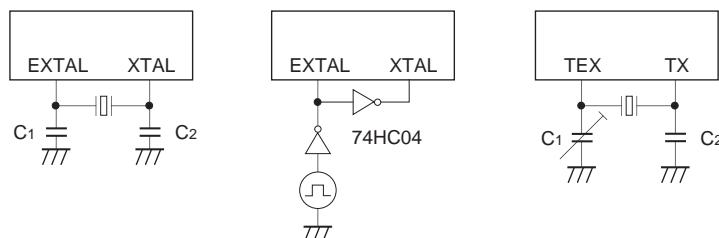
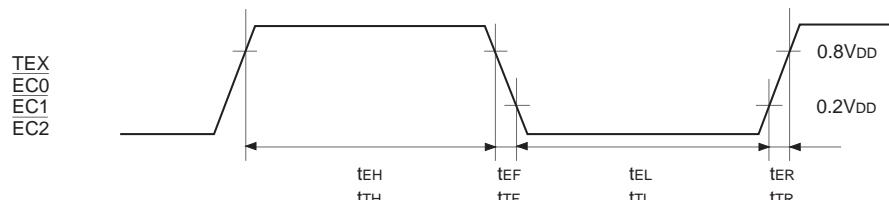
Item	Symbol	Pin	Conditions	Min.	Typ.	Max.	Unit
System clock frequency	fc	XTAL EXTAL	Fig. 1, Fig. 2 V _{DD} = 4.5 to 5.5V	1		24	MHz
				1		12	
System clock input pulse width	t _{XL} , t _{XH}	EXTAL	Fig. 1, Fig. 2 External clock drive V _{DD} = 4.5 to 5.5V	28			ns
				37.5			
System clock input rise time, fall time	t _{CR} , t _{CF}	EXTAL	Fig. 1, Fig. 2 External clock drive			200	ns
Event count input clock pulse width	t _{EH} , t _{EL}	EC	Fig. 3		t _{sys} + 50 ^{*1}		ns
Event count input clock rise time, fall time	t _{ER} , t _{EF}	EC	Fig. 3			20	ms
System clock frequency	fc	TEX TX	V _{DD} = 2.7 to 5.5V Fig. 2 (32kHz clock applied condition)		32.768		kHz
Event count input clock pulse width	t _{TL} , t _{TH}	TEX	Fig. 3	10			μs
Event count input clock rise time, fall time	t _{TR} , t _{TF}	TEX	Fig. 3			20	ms

^{*1} t_{sys} indicates the three values below according to the upper two bits (CPU clock selection) of the clock control register (CLC: 000FEh).

t_{sys} [ns] = 2000/fc (upper two bits = "00"), 4000/fc (upper two bits = "01"), 16000/fc (upper two bits = "11")

**Fig. 1. Clock timing**

Crystal oscillation
Ceramic oscillation External clock 32kHz clock applied conditions
crystal oscillation

**Fig. 2. Clock applied conditions****Fig. 3. Event count clock timing**

(2) Serial transfer (CH0, CH1)

(Ta = -20 to +75°C, V_{DD} = 4.5 to 5.5V, V_{ss} = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Max.	Unit
$\overline{CS} \downarrow \rightarrow SCK$ delay time	t _{DCSK}	SCK0 SCK1	Chip select transfer mode (SCK = output mode)		1.5t _{sys} + 200	ns
$\overline{CS} \uparrow \rightarrow SCK$ floating delay time	t _{DCSKF}	SCK0 SCK1	Chip select transfer mode (SCK = output mode)		1.5t _{sys} + 200	ns
$\overline{CS} \downarrow \rightarrow SO$ delay time	t _{DCSO}	SO0 SO1	Chip select transfer mode		1.5t _{sys} + 200	ns
$\overline{CS} \uparrow \rightarrow SO$ floating delay time	t _{DCSOF}	SO0 SO1	Chip select transfer mode		1.5t _{sys} + 200	ns
\overline{CS} High level width	t _{WHCS}	CS0 CS1	Chip select transfer mode	t _{sys} + 200		ns
\overline{SCK} cycle time	t _{KCY}	SCK0 SCK1	Input mode	2t _{sys} + 200		ns
		SCK0 SCK1	Output mode	8000/fc		ns
SCK High and Low level width	t _{KH} t _{KL}	SCK0 SCK1	Input mode	t _{sys} + 100		ns
		SCK0 SCK1	Output mode	4000/fc - 50		ns
SI input setup time (for $\overline{SCK} \uparrow$)	t _{SIK}	SI0 SI1	\overline{SCK} input mode	-t _{sys} + 100		ns
		SI0 SI1	\overline{SCK} output mode	200		ns
SI input hold time (for $\overline{SCK} \uparrow$)	t _{KSI}	SI0 SI1	\overline{SCK} input mode	2t _{sys} + 200		ns
		SI0 SI1	\overline{SCK} output mode	100		ns
$\overline{SCK} \downarrow \rightarrow SO$ delay time	t _{KSO}	SO0 SO1	\overline{SCK} input mode		2t _{sys} + 200	ns
		SO0 SO1	\overline{SCK} output mode		100	ns

Note 1) t_{sys} indicates three values according to the contents of the clock control register (CLC: 000FEh)
upper 2 bits (CPU clock selection).

t_{sys} [ns] = 2000/fc (upper 2 bits = "00"), 4000/fc (upper 2 bits = "01"), 16000/fc (upper 2 bits = "11")

Note 2) CS, SCK, SI and SO represent CS0, SCK0, SI0 and SO0 for CH0; they represent CS1, SCK1, SI1 and SO1 for CH1, respectively.

Note 3) The load of \overline{SCK} output mode and SO output delay time is 50pF + 1TTL.

Note 4) This case applies that Port I/K output buffer capability switching register (BUFG: 010F5h, bits 6, 5, 4 and 3 = "0, 0, 0, 0") is OFF.

Serial transfer (CH0, CH1)

(Ta = -20 to +75°C, VDD = 2.7 to 3.3V, Vss = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Max.	Unit
$\overline{CS} \downarrow \rightarrow SCK$ delay time	t _{DCSK}	SCK0 SCK1	Chip select transfer mode (SCK = output mode)		1.5t _{sys} + 250	ns
$\overline{CS} \uparrow \rightarrow SCK$ floating delay time	t _{DCSKF}	SCK0 SCK1	Chip select transfer mode (SCK = output mode)		1.5t _{sys} + 250	ns
$\overline{CS} \downarrow \rightarrow SO$ delay time	t _{DCSO}	SO0 SO1	Chip select transfer mode		1.5t _{sys} + 250	ns
$\overline{CS} \uparrow \rightarrow SO$ floating delay time	t _{DCSOF}	SO0 SO1	Chip select transfer mode		1.5t _{sys} + 250	ns
\overline{CS} High level width	t _{WHCS}	CS0 CS1	Chip select transfer mode	t _{sys} + 200		ns
\overline{SCK} cycle time	t _{KCY}	SCK0 SCK1	Input mode	2t _{sys} + 200		ns
			Output mode	8000/fc		ns
SCK High and Low level widths	t _{KH} t _{KL}	SCK0 SCK1	Input mode	t _{sys} + 100		ns
			Output mode	4000/fc – 100		ns
SI input setup time (for $\overline{SCK} \uparrow$)	t _{SIK}	SI0 SI1	SCK input mode	-t _{sys} + 100		ns
			SCK output mode	200		ns
SI input hold time (for $\overline{SCK} \uparrow$)	t _{KSI}	SI0 SI1	SCK input mode	2t _{sys} + 200		ns
			SCK output mode	100		ns
$\overline{SCK} \downarrow \rightarrow SO$ delay time	t _{KSO}	SO0 SO1	SCK input mode		2t _{sys} + 250	ns
			SCK output mode		125	ns

Note 1) t_{sys} indicates three values according to the contents of the clock control register (CLC: 000FEh)
upper 2 bits (CPU clock selection).

t_{sys} [ns] = 2000/fc (upper 2 bits = "00"), 4000/fc (upper 2 bits = "01"), 16000/fc (upper 2 bits = "11")

Note 2) \overline{CS} , \overline{SCK} , SI and SO represent $\overline{CS}0$, $\overline{SCK}0$, SI0 and SO0 for CH0; they represent $\overline{CS}1$, $\overline{SCK}1$, SI1 and SO1 for CH1, respectively.

Note 3) The load of \overline{SCK} output mode and SO output delay time is 50pF.

Note 4) This case applies that Port G/I/K output buffer capability switching register (BUFG: 010F5h, bits 6, 5, 4 and 3 = "1, 1, 1, 1") is ON.

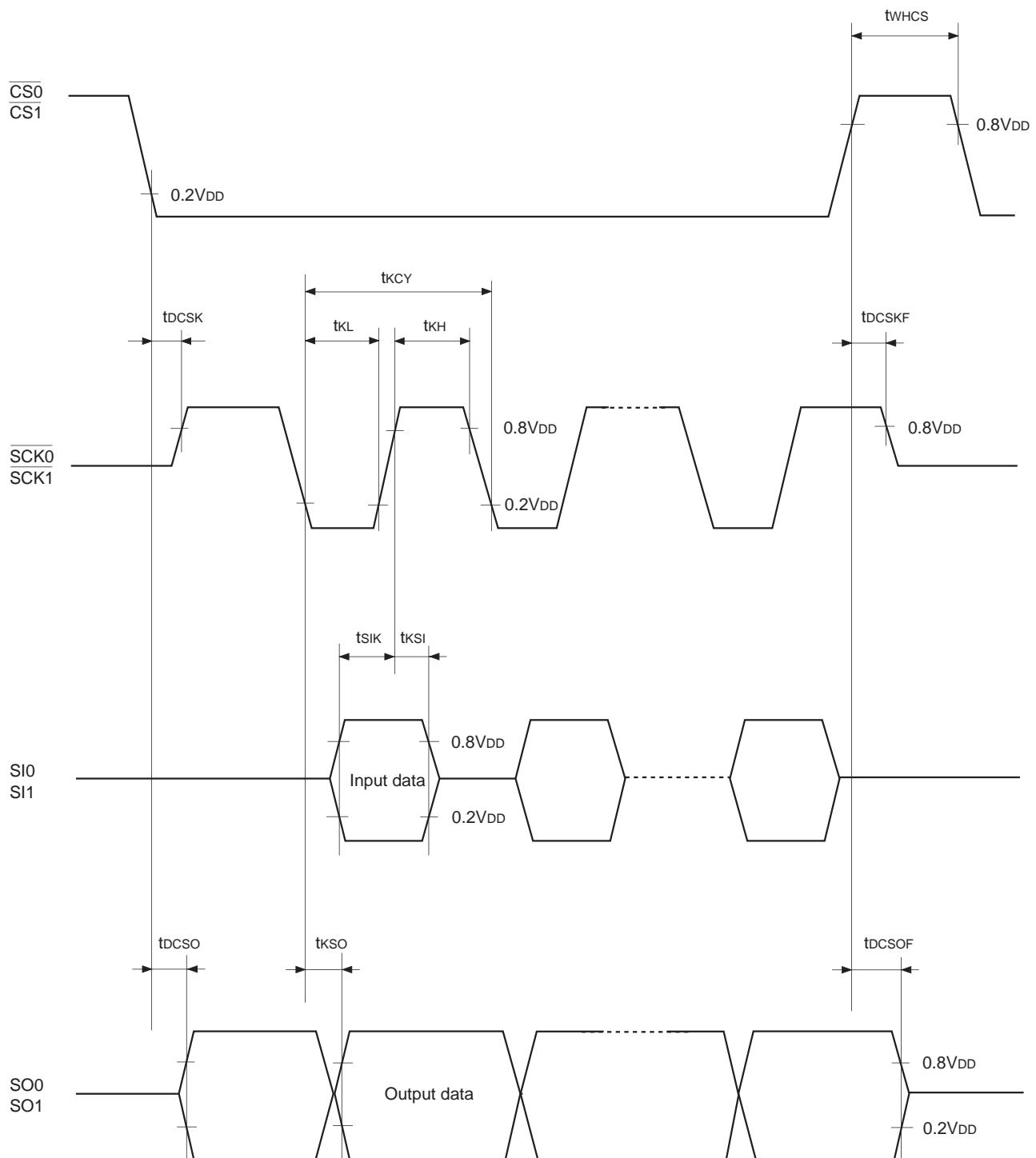


Fig. 4. Serial transfer CH0, CH1 timing

Serial transfer (CH2)(Ta = -20 to +75°C, V_{DD} = 4.5 to 5.5V, V_{ss} = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Max.	Unit
SCK cycle time	t _{KCY}	SCK2	Input mode	1000		ns
			Output mode	8000/fc		ns
SCK High and Low level widths	t _{KH} t _{KL}	SCK2	Input mode	400		ns
			Output mode	4000/fc - 50		ns
SI input setup time (for SCK↑)	t _{SIK}	SI2	SCK input mode	100		ns
			SCK output mode	200		ns
SI input hold time (for SCK↑)	t _{KSI}	SI2	SCK input mode	200		ns
			SCK output mode	100		ns
SCK↓ → SO delay time	t _{KSO}	SO2	SCK input mode		200	ns
			SCK output mode		100	ns

Note 1) tsys indicates three values according to the contents of the clock control register (CLC: 000FEh) upper 2 bits (CPU clock selection).

tsys [ns] = 2000/fc (upper 2 bits = "00"), 4000/fc (upper 2 bits = "01"), 16000/fc (upper 2 bits = "11")

Note 2) SCK, SI and SO represent SCK2, SI2 and SO2 for CH2, respectively.

Note 3) The load of SCK2 output mode and SO2 output delay time is 50pF+1TTL.

Note 4) This case applies that Port B output buffer capability switching register (BUFB: 010F4h, bits 6 and 5 = "0, 0") is OFF.

Serial transfer (CH2)(Ta = -20 to +75°C, V_{DD} = 2.7 to 3.3V, V_{ss} = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Max.	Unit
SCK cycle time	t _{KCY}	SCK2	Input mode	1000		ns
			Output mode	8000/fc		ns
SCK High and Low level widths	t _{KH} t _{KL}	SCK2	Input mode	400		ns
			Output mode	4000/fc - 100		ns
SI input setup time (for SCK↑)	t _{SIK}	SI2	SCK input mode	100		ns
			SCK output mode	200		ns
SI input hold time (for SCK↑)	t _{KSI}	SI2	SCK input mode	200		ns
			SCK output mode	100		ns
SCK↓ → SO delay time	t _{KSO}	SO2	SCK input mode		250	ns
			SCK output mode		125	ns

Note 1) tsys indicates three values according to the contents of the clock control register (CLC: 000FEh) upper 2 bits (CPU clock selection).

tsys [ns] = 2000/fc (upper 2 bits = "00"), 4000/fc (upper 2 bits = "01"), 16000/fc (upper 2 bits = "11")

Note 2) SCK, SI and SO represent SCK2, SI2 and SO2 for CH2, respectively.

Note 3) The load of SCK2 output mode and SO2 output delay time is 50pF.

Note 4) This case applies that Port B output buffer capability switching register (BUFB: 010F4h, bits 6 and 5 = "1, 1") is ON.

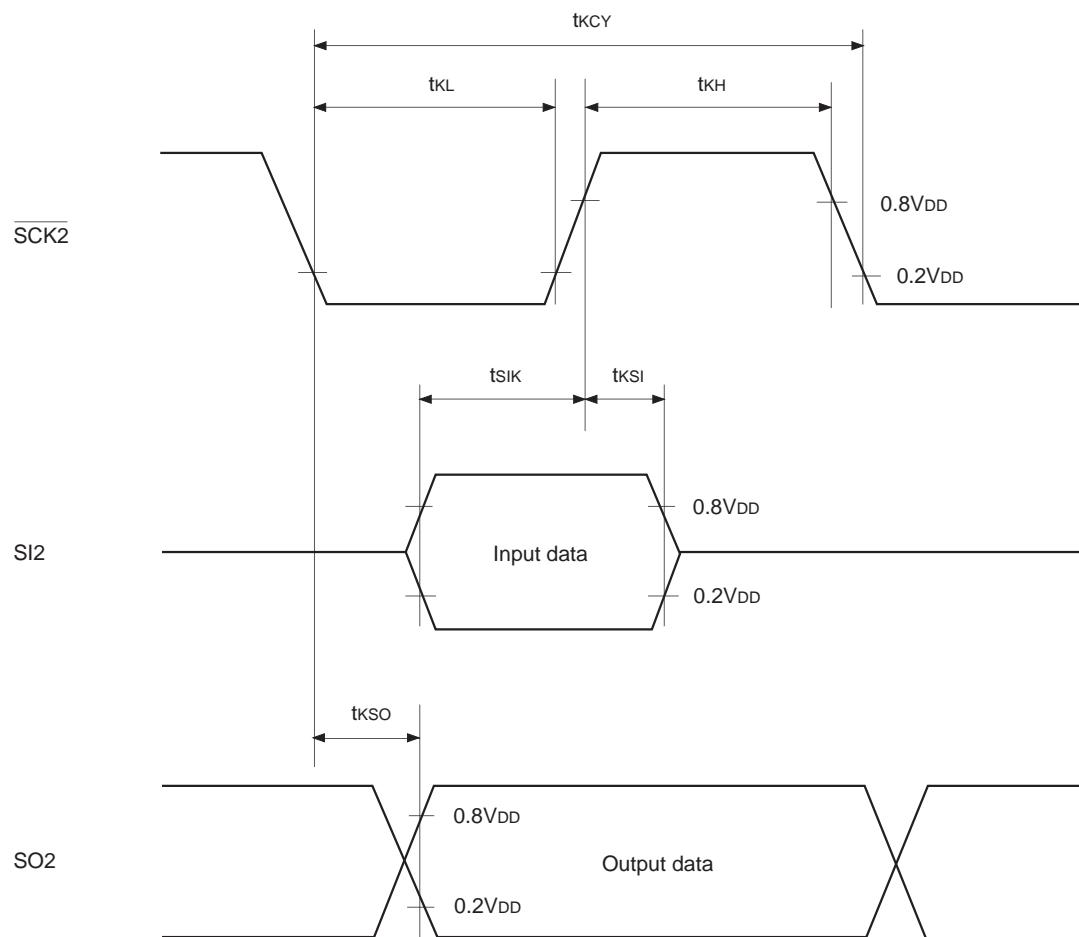


Fig. 5. Serial transfer CH2 timing

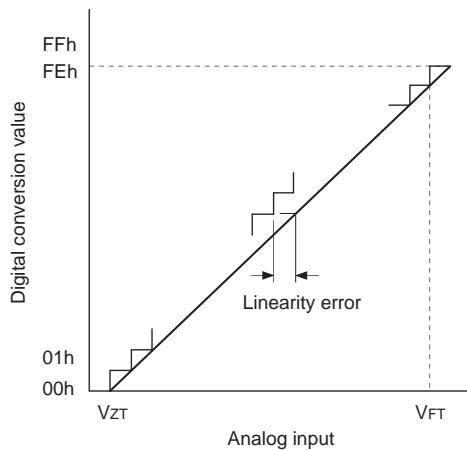
(3) A/D converter characteristics

(Ta = -20 to +75°C, VDD = AVDD = 4.5 to 5.5V, AVREF = 4.0 to AVDD, Vss = AVss = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Typ.	Max.	Unit
Resolution						8	Bits
Linearity error			Ta = 25°C VDD = AVDD = AVREF = 5.0V			±2	LSB
Absolute error			Vss = AVss = 0V			±3	LSB
Conversion time	tCONV			31/fADC ^{*3, *4}			μs
Sampling time	tSAMP			10/fADC ^{*3, *4}			μs
Reference input voltage	VREF	AVREF	VDD = AVDD = 4.5 to 5.5V	AVDD - 0.5			V
Analog input voltage	VIAN	AN0 to AN11		0			V
AVREF current	IREF	AVREF	Operation mode		0.6	1.0	mA
	IREFS		Sleep mode Stop mode 32kHz operation mode			10	μA

(Ta = -20 to +75°C, VDD = AVDD = 2.7 to 3.3V, AVREF = 2.7 to AVDD, Vss = AVss = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Typ.	Max.	Unit
Resolution						8	Bits
Linearity error			Ta = 25°C VDD = AVDD = AVREF = 3.0V			±2	LSB
Absolute error			Vss = AVss = 0V			±3	LSB
Conversion time	tCONV			31/fADC ^{*3, *4}			μs
Sampling time	tSAMP			10/fADC ^{*3, *4}			μs
Reference input voltage	VREF	AVREF	VDD = AVDD = 2.7 to 3.3V	AVDD - 0.3			V
Analog input voltage	VIAN	AN0 to AN11		0			V
AVREF current	IREF	AVREF	Operation mode		0.4	0.7	mA
	IREFS		Sleep mode Stop mode 32kHz operation mode			10	μA



*1 VZT: Value at which the digital conversion value changes from 00h to 01h and vice versa.

*2 VFT: Value at which the digital conversion value changes from FEh to FFh and vice versa.

*3 fADC indicates the below values due to the contents of bit 6 (CKS) of the A/D control register (ADC: 000F9h).

PS3 selected fADC = fc/4

PS4 selected fADC = fc/8

However, when PS3 is selected, fc is 12MHz or less.

*4 Sub clock operated tCONV = 34/fTEX
 tSAMP = 10/fTEX

Fig. 6. Definition of A/D converter terms

(4) Interruption, reset input (Ta = -20 to +75°C, V_{DD} = 2.7 to 5.5V, V_{SS} = 0V reference)

Item	Symbol	Pin	Conditions	Min.	Max.	Unit
External interruption High and Low level widths	t _{IH} t _{IL}	INT0 INT1 INT2 INT3 INT4 NMI		1		μs
Reset input Low level width	t _{RSL}	$\overline{\text{RST}}$		32/fc		μs

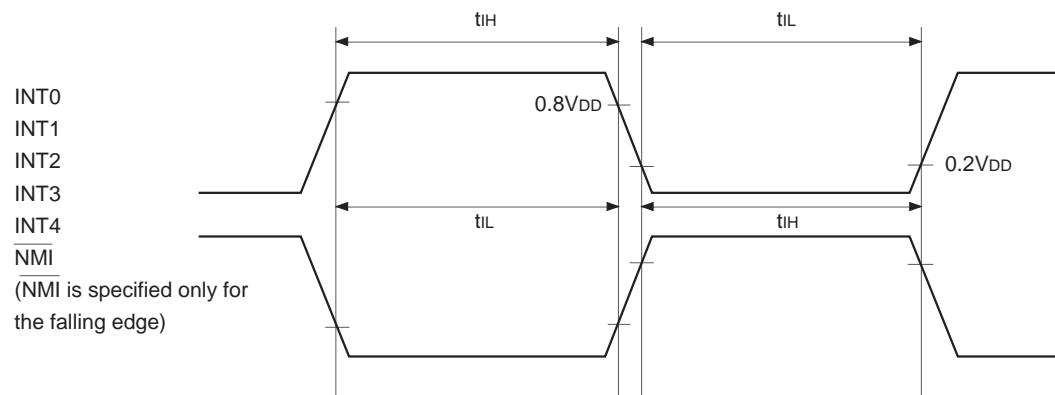


Fig. 7. Interruption input timing

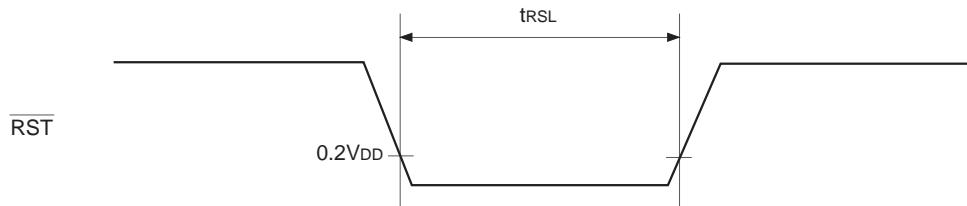
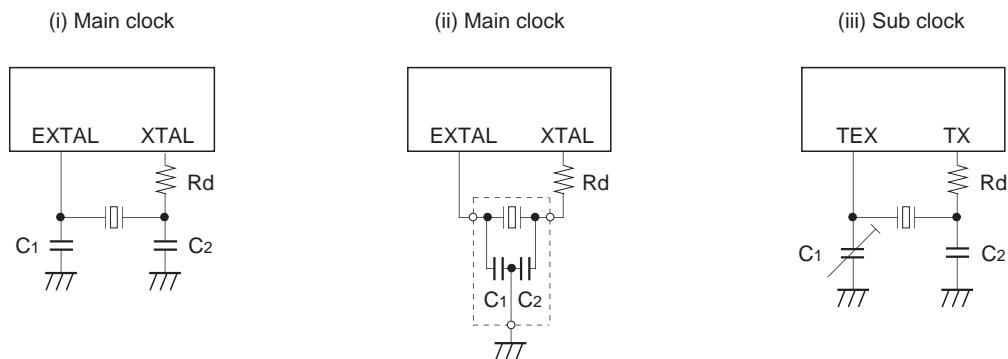


Fig. 8. RST input timing

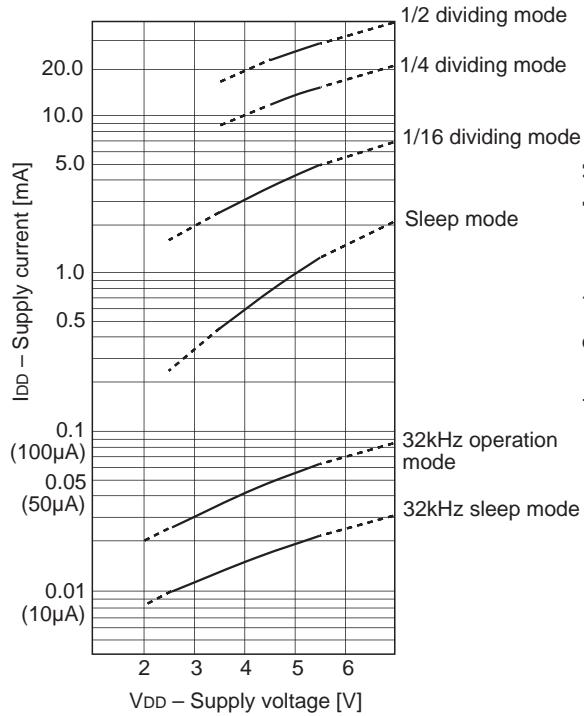
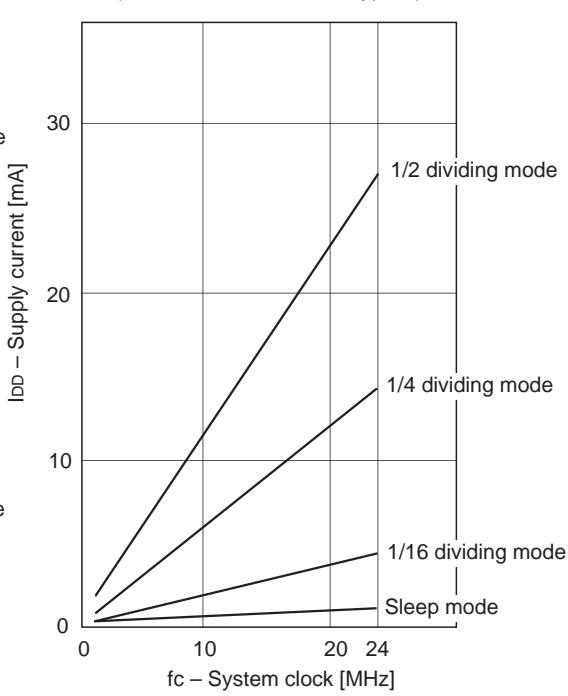
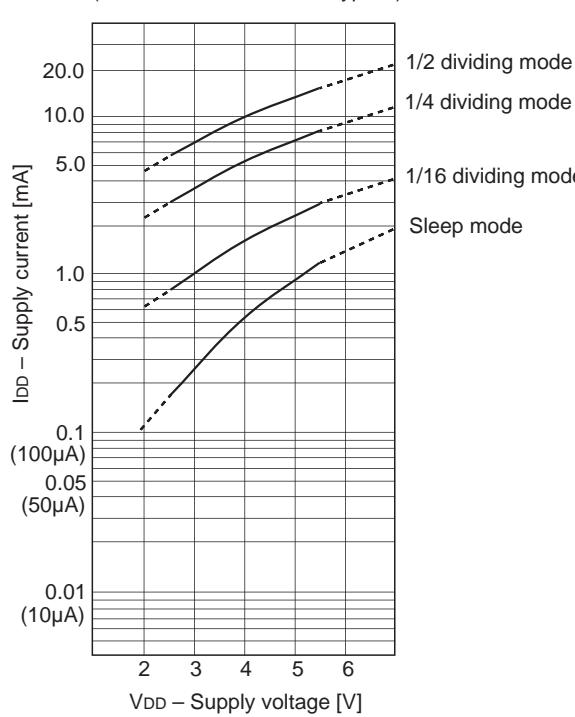
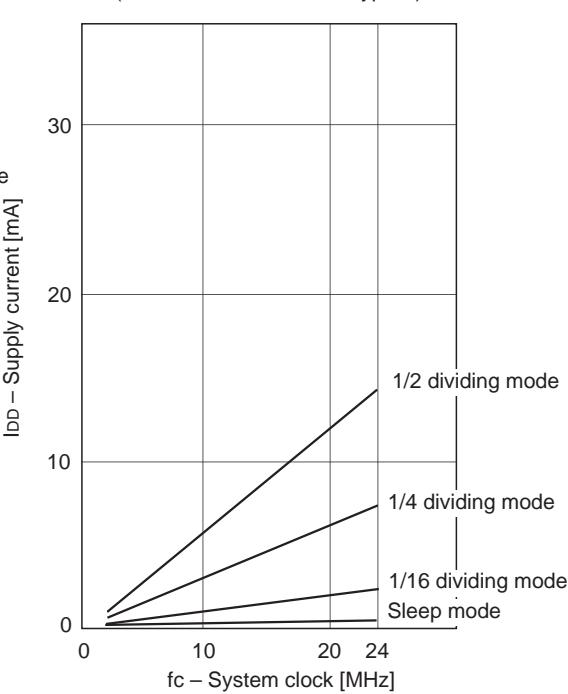
Appendix

Fig. 9. Recommended oscillation circuit

Manufacturer	Model	fc (MHz)	C1 (pF)	C2 (pF)	Rd (Ω)	Circuit example	Remarks		
MURATA MFG CO., LTD.	CSA10.0MTZ	10.0	30	30	0 *1	(i)			
	CSA12.0MTZ	12.0							
	CSA16.00MXZ040	16.0	5	5		(ii)			
	CST10.0MTW*	10.0	30	30					
	CST12.0MTW*	12.0							
	CST16.00MXW0C1*	16.0	5	5					
RIVER ELETEC CO., LTD.	HC-49/U03	8.0	18	18	330 *1	(i)			
		12.0	12	12					
		16.0	10	10					
KINSEKI LTD.	HC-49/U (-S)	8.0	10	10	0 *1				
		12.0	5	5					
		16.0	Open	Open					
	P3	32.768kHz	30	33	120k	(iii)			
Seiko Instruments Inc.	VTC-200 SP-T	32.768kHz	18	18	330k	(iii)	$C_L = 12.5\text{pF}$		

* Indicates types with on-chip grounding capacitor (C1, C2).

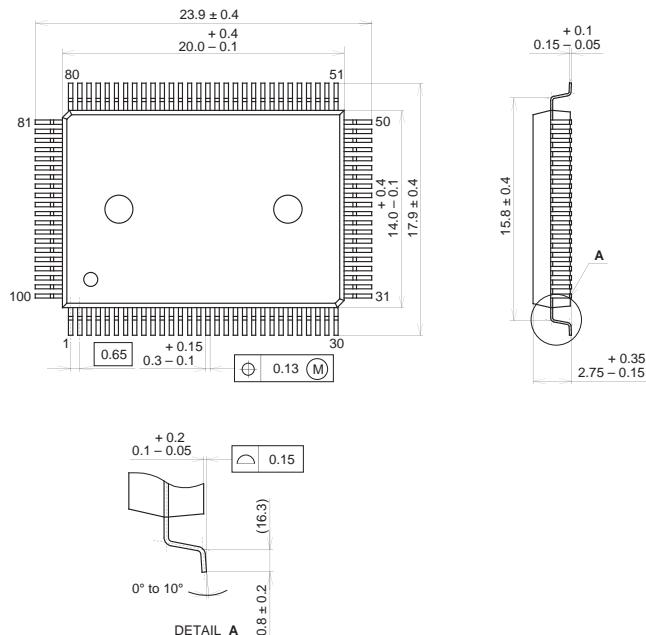
*1 XTAL series resistor ($R_d = 500\Omega$ or less) is hard to affect noise by ESD.

Characteristics Curve**IDD vs. VDD**
($f_c = 24\text{MHz}$, $T_a = 25^\circ\text{C}$, Typical)**IDD vs. f_c**
($V_{DD} = 5.0\text{V}$, $T_a = 25^\circ\text{C}$, Typical)**IDD vs. VDD**
($f_c = 12\text{MHz}$, $T_a = 25^\circ\text{C}$, Typical)**IDD vs. f_c**
($V_{DD} = 3.0\text{V}$, $T_a = 25^\circ\text{C}$, Typical)

Package Outline

Unit: mm

100PIN QFP (PLASTIC)

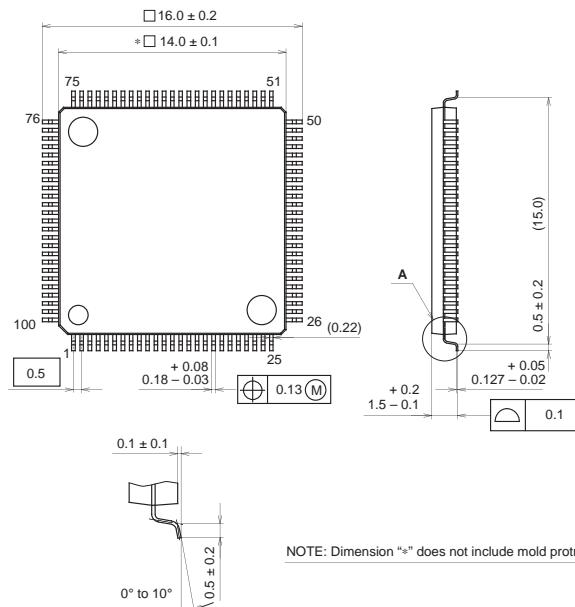


PACKAGE STRUCTURE

SONY CODE	QFP-100P-L01
EIAJ CODE	QFP100-P-1420
JEDEC CODE	_____

PACKAGE MATERIAL	EPOXY RESIN
LEAD TREATMENT	SOLDER PLATING
LEAD MATERIAL	42/COPPER ALLOY
PACKAGE MASS	1.7g

100PIN LQFP (PLASTIC)



NOTE: Dimension "*" does not include mold protrusion.

SONY CODE	LQFP-100P-L01
EIAJ CODE	LQFP100-P-1414
JEDEC CODE	_____

PACKAGE STRUCTURE

PACKAGE MATERIAL	EPOXY RESIN
LEAD TREATMENT	SOLDER PLATING
LEAD MATERIAL	42 ALLOY
PACKAGE MASS	0.8g